

Notice of References Cited

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| Application/Control No. | Applicant(s)/Pate | nt Under |
| 09/627,559 | Reexamination SCHULTZ ET AL | • |
| Examiner | Art Unit | |
| Bernard E Souw | 2881 | Page 1 of 1 |

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| | non men possibility | | | | |
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| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | |
| | U | "The Optics of Spectroscopy", Section 3: "Spectrometer Throughput and Etendue", downloaded from the Internet Website: wysiwyg://18/http://www.jyhoriba.co.uk/jy/oos/oos_ch3.htm | | | |
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Notice of References Cited

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.